Attorney's Docket No.: 10559-591001 ( P12772

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

icant: Alan Wong et al.

Art Unit: 2878

Serial No.:

10/083,877

Examiner: David C. Meyer

Filed

: February 25, 2002

Title

: OPTICAL METROLOGY TARGET DESIGN FOR SIMULTANEOUS

MEASUREMENT OF MULTIPLE PERIODIC STRUCTURES

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

## TRANSMITTAL LETTER

Correspondence relating to this application is enclosed. The required fees are computed below. Please apply any charges not covered, or any credits, to Deposit Account No. 06-1050.

**Total Claims** 

81

90

0

1

\$0

Independent

5

\$86

First Presentation of Multiple Dependent Claims

\$0

Applicant hereby petitions under 37 C.F.R. §1.136 for a 0 month

extension of time.

\$0

TOTAL FEE DUE

\$86

A check for \$86 is attached.

Respectfully submitted,

Scott R. Boalick

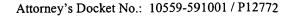
Reg. No. 42,337

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Serial No.: 10/083,877 Examiner: David C. Meyer Filed: February 25, 2002 Assignee: Intel Corporation

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Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## **AMENDMENT IN REPLY TO ACTION OF NOVEMBER 7, 2003**

Please amend the above-identified application as follows:

Amendments to the claims are reflected in the listing of claims, which begins on page 2 of this paper.

Remarks begin on page 14 of this paper.

